DESCRIPTION
The MP6909 is a low-drop diode emulator IC that, when combined with an external switch, replaces Schottky diodes in high-efficiency flyback converters. The MP6909 regulates the forward drop of an external synchronous rectifier (SR) MOSFET to about 40mV, which switches off once the voltage becomes negative.

The MP6909 can generate its own supply voltage via an internal linear regulator. Programmable ringing detection circuitry prevents the MP6909 from turning on falsely at $V_{DS}$ oscillations during discontinuous conduction mode (DCM) and quasi-resonant operation.

The MP6909 is available in a space-saving TSOT23-6 package.

FEATURES
- Supplied Voltage Internally Regulated
- Ringing Detection Prevents False Turn-On during DCM and Quasi-Resonant Operations
- Works with Standard and Logic Level SR MOSFETs
- Compatible with Energy Star
- ~30ns Fast Turn-Off and Turn-On Delay
- ~100µA Quiescent Current
- Supports DCM, CCM, and Quasi-Resonant Operations
- Supports both High-Side and Low-Side Rectification
- Available in a TSOT23-6 Package

APPLICATIONS
- USB PD Quick Chargers
- Adaptors
- Flyback Converters

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ORDERING INFORMATION

<table>
<thead>
<tr>
<th>Part Number*</th>
<th>Package</th>
<th>Top Marking</th>
</tr>
</thead>
<tbody>
<tr>
<td>MP6909GJ</td>
<td>TSOT23-6</td>
<td>See Below</td>
</tr>
</tbody>
</table>

* For Tape & Reel, add suffix –Z (e.g.: MP6909GJ–Z).

TOP MARKING

| BDRY |

BDR: Product code of MP6909GJ
Y: Year code

PACKAGE REFERENCE

![Top View Diagram of TSOT23-6 Package](image-url)
**ABSOLUTE MAXIMUM RATINGS**

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Rating</th>
</tr>
</thead>
<tbody>
<tr>
<td>SL to VSS</td>
<td>-0.3V to +6.5V</td>
</tr>
<tr>
<td>VR, VG to VSS</td>
<td>-0.3V to +14V</td>
</tr>
<tr>
<td>VD, VIN to VSS</td>
<td>-1V to +180V</td>
</tr>
</tbody>
</table>

Continuous power dissipation ($T_A = +25°C$)

- 0.56W

**Junction temperature**

- 150°C

**Lead temperature (solder)**

- 260°C

**Storage temperature**

- -55°C to +150°C

**Recommended Operation Conditions**

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Rating</th>
</tr>
</thead>
<tbody>
<tr>
<td>VR to VSS</td>
<td>4V to 13V</td>
</tr>
<tr>
<td>VD, VIN, to VSS</td>
<td>-1V to +150V</td>
</tr>
</tbody>
</table>

**Maximum junction temp. ($T_J$)**

- 125°C

**Thermal Resistance**

<table>
<thead>
<tr>
<th>Package</th>
<th>$\theta_JA$</th>
<th>$\theta_JC$</th>
</tr>
</thead>
<tbody>
<tr>
<td>TSOT23-6</td>
<td>220°C/W</td>
<td>110°C/W</td>
</tr>
</tbody>
</table>

**NOTES:**

1) Exceeding these ratings may damage the device.

2) The maximum allowable power dissipation is a function of the maximum junction temperature $T_J$(MAX), the junction-to-ambient thermal resistance $\theta_{JA}$, and the ambient temperature $T_A$. The maximum allowable continuous power dissipation at any ambient temperature is calculated by $P_D(\text{MAX})=(T_J(\text{MAX})-T_A)/\theta_{JA}$. Exceeding the maximum allowable power dissipation produces an excessive die temperature, causing the regulator to go into thermal shutdown. Internal thermal shutdown circuitry protects the device from permanent damage.

3) The device is not guaranteed to function outside of its operating conditions.

4) Measured on JESD51-7, 4-layer PCB.
## ELECTRICAL CHARACTERISTICS

VR = 9V, -40°C ≤ TJ ≤ +125°C, unless otherwise noted.

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Symbol</th>
<th>Conditions</th>
<th>Min</th>
<th>Typ</th>
<th>Max</th>
<th>Units</th>
</tr>
</thead>
<tbody>
<tr>
<td>Supply Management Section</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>VR UVLO rising</td>
<td>VR</td>
<td>VR = 7V, VIN = 40V</td>
<td>3.55</td>
<td>3.75</td>
<td>3.95</td>
<td>V</td>
</tr>
<tr>
<td>VR UVLO hysteresis</td>
<td>VR</td>
<td></td>
<td>0.1</td>
<td>0.2</td>
<td>0.3</td>
<td>V</td>
</tr>
<tr>
<td>VR maximum charging current</td>
<td>IVR</td>
<td></td>
<td>70</td>
<td>mA</td>
<td></td>
<td></td>
</tr>
<tr>
<td>VR regulation voltage</td>
<td>VCC</td>
<td>VIN = 12V</td>
<td>8.5</td>
<td>9</td>
<td>9.5</td>
<td>V</td>
</tr>
<tr>
<td>Operating current</td>
<td>ICC</td>
<td>VR = 9V, CLOAD = 2.2nF, FSW = 100kHz</td>
<td>2.9</td>
<td>3.5</td>
<td>mA</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>VR = 5V, CLOAD = 2.2nF, FSW = 100kHz</td>
<td>1.72</td>
<td>2.1</td>
<td>mA</td>
<td></td>
</tr>
<tr>
<td>Quiescent current</td>
<td>IQ(VR)</td>
<td>VR = 14V</td>
<td>105</td>
<td>135</td>
<td>µA</td>
<td></td>
</tr>
<tr>
<td>Shutdown current</td>
<td>ISD(VR)</td>
<td>VR = UVLO - 0.1V</td>
<td>100</td>
<td>µA</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Control Circuitry Section</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Forward regulation voltage (VSS - VD)</td>
<td>Vfwd</td>
<td></td>
<td>25</td>
<td>40</td>
<td>55</td>
<td>mV</td>
</tr>
<tr>
<td>Turn-on threshold (VDS)</td>
<td>TDon</td>
<td>CLOAD = 2.2nF</td>
<td>-115</td>
<td>-86</td>
<td>-57</td>
<td>mV</td>
</tr>
<tr>
<td>Turn-off threshold (VSS - VD)</td>
<td>TDooff</td>
<td></td>
<td>-6</td>
<td>3</td>
<td>12</td>
<td>mV</td>
</tr>
<tr>
<td>Turn-on delay</td>
<td>TDon</td>
<td>CLOAD = 2.2nF</td>
<td>30</td>
<td>50</td>
<td>ns</td>
<td></td>
</tr>
<tr>
<td>Turn-off delay</td>
<td>TDooff</td>
<td>CLOAD = 2.2nF</td>
<td>25</td>
<td>45</td>
<td>ns</td>
<td></td>
</tr>
<tr>
<td>Turn-on blanking time</td>
<td>TBO-ON</td>
<td>CLOAD = 2.2nF</td>
<td>0.75</td>
<td>1.1</td>
<td>1.45</td>
<td>µs</td>
</tr>
<tr>
<td>Turn-off blanking exit threshold</td>
<td>VB-OFF</td>
<td></td>
<td>2</td>
<td>3</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>Turn-off threshold during turn-on blanking</td>
<td></td>
<td></td>
<td>1.3</td>
<td>1.8</td>
<td>2.1</td>
<td>V</td>
</tr>
<tr>
<td>Turn-on slew rate detection timer</td>
<td>TSLEW</td>
<td>RSLEW = 400kΩ</td>
<td>51</td>
<td>76</td>
<td>101</td>
<td>ns</td>
</tr>
<tr>
<td>Gate Driver Section</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>VG (low)</td>
<td>VG-L</td>
<td>ILOAD = 10mA</td>
<td>0.01</td>
<td>0.02</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>VG (high)</td>
<td>VG-H</td>
<td>ILOAD = 0</td>
<td>VR</td>
<td></td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>Maximum source current</td>
<td></td>
<td></td>
<td>0.5</td>
<td></td>
<td>A</td>
<td></td>
</tr>
<tr>
<td>Maximum sink current</td>
<td></td>
<td></td>
<td>3</td>
<td></td>
<td>A</td>
<td></td>
</tr>
<tr>
<td>Pull-down impedance</td>
<td></td>
<td>Same as VG (low)</td>
<td>1</td>
<td>2</td>
<td></td>
<td>Ω</td>
</tr>
</tbody>
</table>

**NOTE:**

5) Guaranteed by characterization and design.
TYPICAL PERFORMANCE CHARACTERISTICS

Operating Current vs. Temperature
VR = 9V, CLOAD = 2.2nF, FSW = 100kHz

Quiescent Current vs. Temperature
VR = 14V

Turn-On Delay vs. Temperature
VR = 9V, CLOAD = 2.2nF

Turn-Off Delay vs. Temperature
VR = 9V, CLOAD = 2.2nF

Forward Regulation Voltage (VSS - VD) vs. Temperature

Turn-On Slew Rate Detection Timer vs. Temperature
R_{SLEW} = 400kΩ
**TYPICAL PERFORMANCE CHARACTERISTICS (continued)**

VR Maximum Charging Current vs. Temperature
VR = 7V, VIN = 40V
TYPICAL PERFORMANCE CHARACTERISTICS (continued)

Operation in 36W Flyback Application
VIN = 110VAC, VOUT = 12V, IOUT = 3A

Operation in 36W Flyback Application
VIN = 220VAC, VOUT = 12V, IOUT = 3A
## PIN FUNCTIONS

<table>
<thead>
<tr>
<th>Pin #</th>
<th>Name</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>VIN</td>
<td>Internal linear regulator input.</td>
</tr>
<tr>
<td>2</td>
<td>VSS</td>
<td>Ground. VSS is also used as a MOSFET source sense reference for VD.</td>
</tr>
<tr>
<td>3</td>
<td>SL</td>
<td>Programming for turn-on signal slew rate detection. SL prevents the SR controller from turning on falsely by ringing below the turn-on threshold at VD in discontinuous conduction mode (DCM) and quasi-resonant mode. Any signal slower than the pre-set slew rate cannot turn on VG.</td>
</tr>
<tr>
<td>4</td>
<td>VR</td>
<td>Internal linear regulator output. VR is the supply of the MP6909.</td>
</tr>
<tr>
<td>5</td>
<td>VG</td>
<td>Gate drive output.</td>
</tr>
<tr>
<td>6</td>
<td>VD</td>
<td>MOSFET drain voltage sense.</td>
</tr>
</tbody>
</table>
Figure 1: Functional Block Diagram
OPERATION

The MP6909 supports operation in discontinuous conduction mode (DCM), continuous conduction mode (CCM), and quasi-resonant flyback converters. The control circuitry controls the gate in forward mode and turns the gate off when the synchronous rectification (SR) MOSFET current drops to zero.

VR Generation

VIN is the input of the internal linear regulator. VR is the output of the internal linear regulator. The capacitor at VR supplies power for the IC.

When VIN < 9.3V, the internal linear regulator regulates VR at VIN-0.3V.

When VIN > 9.3V, the internal linear regulator regulates VR at 9V.

Start-Up and Under-Voltage Lockout (UVLO)

When VR rises above 3.75V, the MP6909 exits under-voltage lockout (UVLO) and is enabled. The MP6909 enters sleep mode, and VGS is kept low once VR drops below 3.55V.

Turn-On Phase

When VDS drops to ~2V, a turn-on timer begins to count. This turn-on timer can be programmed by an external resistor on SL. If VDS reaches the -86mV turn-on threshold from 2V within the time (T_{SLEW}) set by the timer, the MOSFET is turned on after a turn-on delay (about 30ns) (see Figure 2). If VDS crosses -86mV after the timer ends, the gate voltage (V_G) remains off. This turn-on timer prevents the MP6909 from turning on falsely due to ringing from DCM and quasi-resonant operations.

\[ T_{SLEW} = R_{SLEW} \times \frac{76\text{ns}}{400\text{k}\Omega} \] (1)

Turn-On Blanking

The control circuitry contains a blanking function. When the MOSFET turns on, the control circuit ensures that the on state lasts for a specific period of time. The turn-on blanking time is ~1.1µs to prevent an accidental turn-off due to ringing. However, if VDS reaches the turn-on threshold during turn-on blanking within the turn-on blanking time, VGS is pulled low immediately.

Conduction Phase

When VDS rises above the forward voltage drop (-40mV) according to the decrease of the switching current, the MP6909 lowers the gate voltage level to enlarge the on resistance of the synchronous MOSFET.

Figure 2: Turn-On/Turn-Off Timing Diagram

With this control scheme, VDS is adjusted to be around -40mV even when the current through the MOSFET is fairly low. This function keeps the driver voltage at a very low level when the synchronous MOSFET is turned off, which boosts the turn-off speed and is especially important for CCM operation.

Turn-Off Phase

When VDS rises to trigger the turn-off threshold (-3mV), the gate voltage is pulled to zero after a very short turn-off delay of 25ns (see Figure 2).

Turn-Off Blanking

After the gate driver (VGS) is pulled to zero by VDS reaching the turn-off threshold (-3mV), a turn-off blanking time is applied, during which the gate driver signal is latched off. The turn-off blanking is removed when VDS rises above the turn-off blanking exit threshold (2 - 3V) (see Figure 2).
APPLICATION INFORMATION

Slew Rate Detection Function

In DCM operations, the demagnetizing ringing may bring V_DS down below 0V. If V_DS reaches the turn-on threshold during the ringing, SR controllers without the slew rate detection function may turn on the MOSFET by mistake. Figure 3 shows the waveform of this false turn-on situation. This increases power loss and may also lead to shoot-through if the primary side MOSFET is turned on within the turn-on blanking time.

Figure 3: False Turn-On (without Slew Rate Detection)

Considering that the slew rate of the ringing is always much less than when the primary MOSFET is actually turned off, this false turn-on situation can be prevented by the slew rate detection function (see Figure 4). When the slew rate is less than the threshold set by \( R_{SLEW} \), the IC does not turn on the gate even when V_DS reaches the turn-on threshold.

Figure 4: Preventing a False Turn-On (with Slew Rate Detection)

External Resistor on VD

Since over-voltage conditions may damage the device, there must be appropriate application designs to guarantee safe operation, especially on the high-voltage pin.

A common over-voltage condition is where the body diode of the SR MOSFET is turned on and the forward voltage drop may exceed the negative rating on VD. In this case, an external resistor should be placed between VD and the MOSFET drain. Generally, the resistance is recommended to be no less than 300\( \Omega \).

On the other hand, this resistor cannot be too large, since large resistor values slow down the slew rate on V_DS detection. Generally, it is not recommended to use any resistance value larger than 1k\( \Omega \) but should be checked based on the slew rate for each practical case.

Typical System Implementations

Figure 5 shows the typical system implementation for the IC power supply derived from the output voltage, which is available in low-side rectification.

Figure 5: MP6909 in Low-Side Rectification

Figure 6 shows the circuit configuration for the auxiliary winding solution for the MP6909 used in high-side rectification.

Figure 6: MP6909 in High-Side Rectification
SR MOSFET Selection

Power MOSFET selection is a tradeoff between the $R_{DS(ON)}$ and $Q_G$. To achieve higher efficiency, a MOSFET with a smaller $R_{DS(ON)}$ is preferred. Typically, $Q_G$ is larger with a smaller $R_{DS(ON)}$, which makes the turn-on/turn-off speed lower and leads to larger power loss and driver loss. Because $V_{DS}$ is adjusted at about -40mV during the driving period when the switching current is fairly small, a MOSFET with an $R_{DS(ON)}$ that is too low is not recommended because the gate driver is pulled low when $V_{DS} = -I_{SD} \times R_{DS(ON)}$ becomes larger than -40mV. The MOSFET’s $R_{DS(ON)}$ does not contribute to the conduction loss. The conduction loss is $P_{CON} = -V_{DS} \times I_{SD} \approx I_{SD} \times 40mV$.

To achieve fairly high use of the MOSFET’s $R_{DS(ON)}$, the MOSFET should be turned on completely for at least 50% of the SR conduction period. Calculate $V_{DS}$ with Equation (2):

$$V_{DS} = -I_C \times R_{DS(ON)} = -I_{OUT} / D \times R_{DS(ON)} \leq V_{fwd} \quad (2)$$

Where $V_{DS}$ is drain-source voltage of the MOSFET, $D$ is the duty cycle of the secondary side, $I_{OUT}$ is output current, and $V_{fwd}$ is the forward voltage threshold (~40mV).

Figure 7 shows the typical waveform of a flyback application. Assume it has a 50% duty cycle. The MOSFET’s $R_{DS(ON)}$ is recommended to be no lower than $-20/I_{OUT}$ mΩ. For a 5A application, the $R_{DS(ON)}$ should be no lower than 4mΩ.

Slew Rate Set-Up

Select the slew rate set-up resistor carefully. Before placing a resistor on SL, measure the $V_{DS}$ slew rate during normal turn-on and oscillation during DCM. Choose a resistor that can guarantee a normal SR driver turn-on. For example, if the $V_{DS}$ slew rate is -1V/ns during the normal drop and 0.01V/ns in oscillation, a 0.1V/ns slew rate is a proper target to set up.

PCB Layout Guidelines

Efficient PCB layout is critical for stable operation. For best results, refer to Figure 8, Figure 9, Figure 10, and follow the guidelines below.

Sensing for VD/VSS

1. Make the sensing connection (VD/VSS) as close as possible to the MOSFET (drain/source).
2. Make the sensing loop as small as possible.
3. Keep the IC out of the power loop to prevent the sensing loop and power loop from interrupting each other (see Figure 8).

4. Place a decoupling ceramic capacitor from VR to PGND close to the IC for adequate filtering.

Gate Driver Loop

1. Make the gate driver loop as small as possible to minimize the parasitic inductance.
2. Keep the driver signal far away from the VD sensing trace on the layout.
Layout Example

Figure 9 shows a layout example of a single layer with a through-hole transformer and a TO220 package SR MOSFET. RSN and CSN are the RC snubber network for the SR MOSFET. The sensing loop (VD and VSS to the SR MOSFET) is minimized and kept separate from the power loop. The VR decoupling capacitor (C2) is placed beside VR.

Figure 10 shows another layout example of a single layer with a PowerPAK/SO8 package SR MOSFET, which also has a minimized sensing loop and power loop to prevent the loops from interfering with one another.

Figure 9: Layout Example with TO220 Package SR MOSFET

Figure 10: Layout Example with PowerPAK/SO8 SR MOSFET
PACKAGE INFORMATION

TSOT23-6

TOP VIEW

RECOMMENDED LAND PATTERN

FRONT VIEW

SIDE VIEW

NOTE:
1) ALL DIMENSIONS ARE IN MILLIMETERS.
2) PACKAGE LENGTH DOES NOT INCLUDE MOLD FLASH, PROTRUSION OR GATE BURR.
3) PACKAGE WIDTH DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION.
4) LEAD COPLANARITY (BOTTOM OF LEADS AFTER FORMING) SHALL BE 0.10 MILLIMETERS MAX.
5) DRAWING CONFORMS TO JEDEC MO-193, VARIATION AB.
6) DRAWING IS NOT TO SCALE.
7) PIN 1 IS LOWER LEFT PIN WHEN READING TOP MARK FROM LEFT TO RIGHT, (SEE EXAMPLE TOP MARK)

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